

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10585642	YANO ET AL.
	Examiner	Art Unit
	Rachel L Zhang	1795

SEARCHED

Class	Subclass	Date	Examiner
430	48, 108.2	6/3/2010	RLB
528	361	6/3/2010	RLB
399	130, 50	6/3/2010	RLB
430	111.32, 111.35	12/01/2010	RLZ

SEARCH NOTES

Search Notes	Date	Examiner
inventorship search	6/3/2010	RLB
text searc in EAST (see search history)h	6/3/2010	RLB
consulted with SPE Mark Huff	6/3/2010	RLB
updated text search in EAST (see search history)	12/01/2010	RLZ
consulted with Chris RoDee	12/01/2010	RLZ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
430	111.32, 111.35, 48, 108.2	08/25/2011	rlz
528	361	08/25/2011	rlz
399	130, 50	08/25/2011	rlz

/R. L. Z./
Examiner.Art Unit 1721